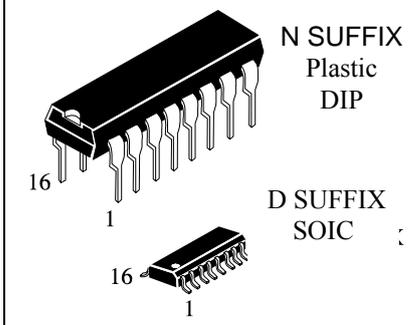


CMOS BCD-to-7-Segment Latch Decoder Drivers

IW4511B

ICs IW4511B is used in high-performance computing systems with low power consumption in portable measuring equipments, communication devices with power supply from telephone networks, instruments using alternative power supplies (solar batteries, thermal elements) etc.

- Standard symmetrical output characteristic
- Operating Voltage Range: 3.0 to 18 V
- 100% testing for quiescent current at 20V
- Maximum input current of 1 μ A at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
- Noise margin (over full package temperature range):
 - 1.0 V min @ 5.0 V supply
 - 2.0 V min @ 10.0 V supply
 - 2.5 V min @ 15.0 V supply

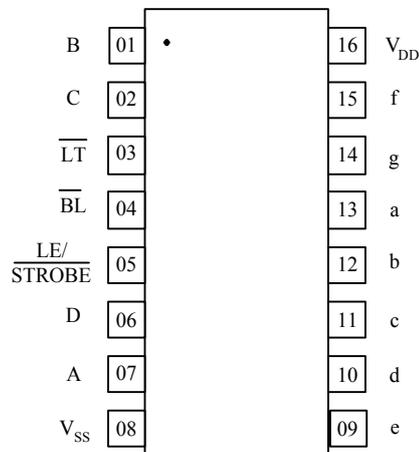


N SUFFIX
Plastic
DIP

D SUFFIX
SOIC

ORDERING INFORMATION
 IW4511BN Plastic DIP
 IW4511BD SOIC
 $T_A = -55$ to 125 °C for all packages

PIN ASSIGNMENT



TRUTH TABLE

| Inputs | | | | | | | Outputs | | | | | | | Display |
|--------|----|----|---|---|---|---|---------|---|---|---|---|---|---|---------|
| LE | BL | LT | D | C | B | A | a | b | c | d | e | f | g | |
| X | X | L | X | X | X | X | H | H | H | H | H | H | H | 8 |
| X | L | H | X | X | X | X | L | L | L | L | L | L | L | blank |
| L | H | H | L | L | L | L | H | H | H | H | H | H | L | 0 |
| L | H | H | L | L | L | H | L | H | H | L | L | L | L | 1 |
| L | H | H | L | L | H | L | H | H | L | H | H | L | H | 2 |
| L | H | H | L | L | H | H | H | H | H | H | L | L | H | 3 |
| L | H | H | L | H | L | L | L | H | H | L | L | H | H | 4 |
| L | H | H | L | H | L | H | H | L | H | H | L | H | H | 5 |
| L | H | H | L | H | H | L | L | L | H | H | H | H | H | 6 |
| L | H | H | L | H | H | H | H | H | H | L | L | L | L | 7 |
| L | H | H | H | L | L | L | H | H | H | H | H | H | H | 8 |
| L | H | H | H | L | L | H | H | H | H | L | L | H | H | 9 |
| L | H | H | H | L | H | L | L | L | L | L | L | L | L | blank |
| L | H | H | H | L | H | H | L | L | L | L | L | L | L | blank |
| L | H | H | H | H | L | L | L | L | L | L | L | L | L | blank |
| L | H | H | H | H | L | H | L | L | L | L | L | L | L | blank |
| L | H | H | H | H | H | H | L | L | L | L | L | L | L | blank |
| H | H | H | X | X | X | X | * | | | | | | | * |

* - Depends on BCD code previously, applied when LE=L
X – Don't Care

MAXIMUM RATINGS

| Symbol | Parameter | Recommended operating conditions | | Maximum ratings | | Unit |
|-----------|---|----------------------------------|-----|-----------------|--------------|------|
| | | min | max | min | max | |
| V_{DD} | DC Supply Voltage | 3 | 18 | -0.5 | 20 | V |
| V_I | Input Voltage Range | - | - | -0.5 | $V_{DD}+0.5$ | V |
| V_O | Output Voltage Range | - | - | -0.5 | $V_{DD}+0.5$ | V |
| I_I | DC Input Current | - | - | - | ± 10 | mA |
| P_D | Power dissipation per package | - | - | - | 500* | mW |
| P_{tot} | Power Dissipation per Output Transistor | - | - | - | 100 | mW |

* P_D for IW4511BN for temperature range - 55 - +100 °C and for ICs IW4511BD for temperature range - 55 - +65 °C
 P_D for IW4511BN derate linearity at 12 mW/°C for temperature range +100 - +125°C.
 P_D for IW4511BD derate linearity at 7 mW/°C for temperature range +65- +125°C.

STATIC ELECTRICAL CHARACTERISTIC

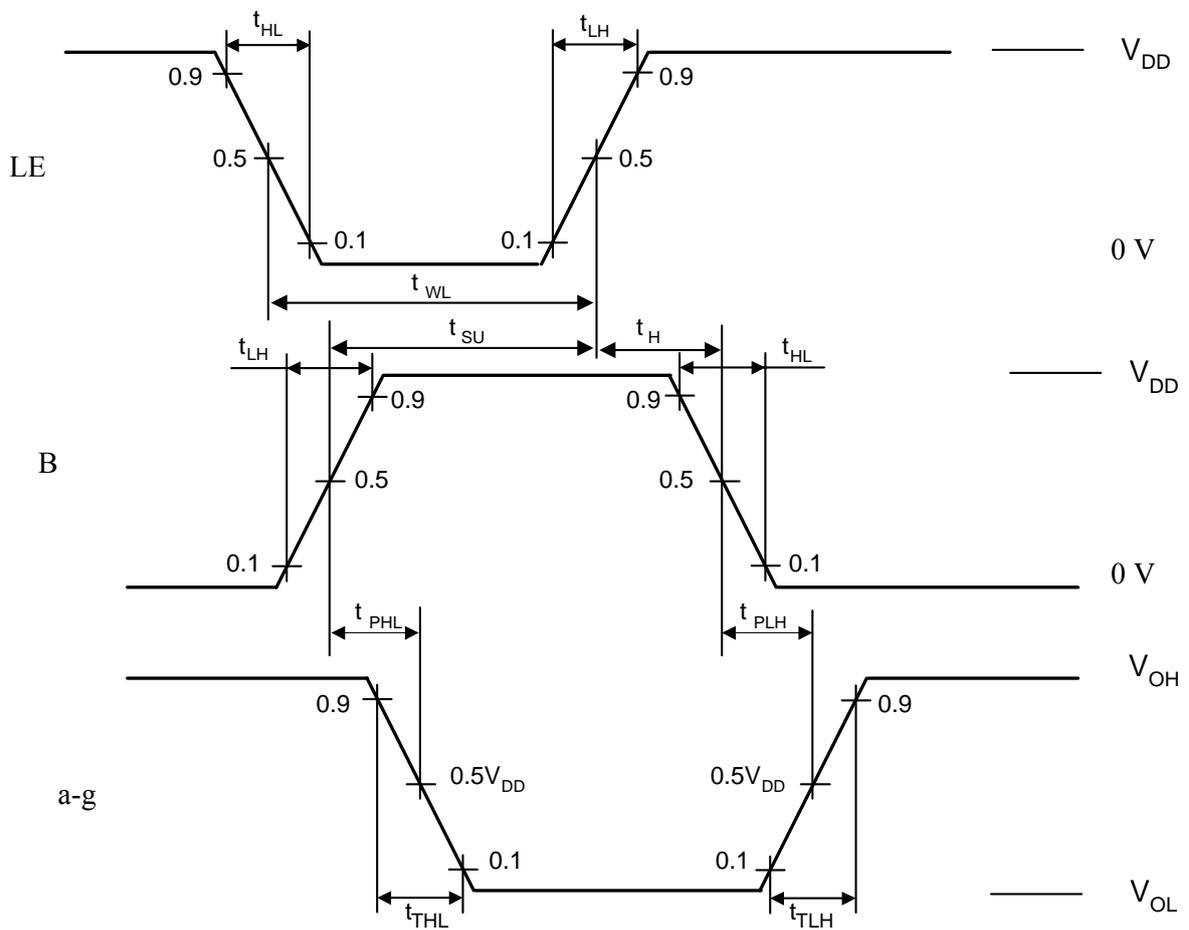
| Symbol | Parameter | Test conditions | V _{DD} , V | Guaranteed Limits | | | | | | Units |
|-----------------|----------------------------------|--|------------------------|-------------------|------|-------|------|-------|------|-------|
| | | | | -55°C | | 25°C | | 125°C | | |
| | | | | min | max | min | max | min | max | |
| V _{IH} | Minimum High-Level Input Voltage | V _O = 0.5 V or V _{DD} -1.2 V | 5.0 | 3.5 | - | 3.5 | - | 3.5 | - | V |
| | | V _O = 1.0 V or V _{DD} -1.2 V | 10 | 7.0 | - | 7.0 | - | 7.0 | - | |
| | | V _O = 1.5 V or V _{DD} -1.2 V | 15 | 11 | - | 11 | - | 11 | - | |
| V _{IL} | Maximum Low-Level Input Voltage | V _O = 0.5 V or V _{DD} -1.2 V | 5.0 | - | 1.5 | - | 1.5 | - | 1.5 | V |
| | | V _O = 1.0 V or V _{DD} -1.2 V | 10 | - | 3.0 | - | 3.0 | - | 3.0 | |
| | | V _O = 1.5 V or V _{DD} -1.2 V | 15 | - | 4.0 | - | 4.0 | - | 4.0 | |
| V _{OH} | High-Level Output Voltage | V _I = V _{SS} or V _{DD} | 5.0 | 4.0 | - | 4.1 | - | 4.2 | - | V |
| | | | 10 | 9.0 | - | 9.1 | - | 9.2 | - | |
| | | | 15 | 14.0 | - | 14.1 | - | 14.2 | - | |
| V _{OL} | Low-Level Output Voltage | V _I = V _{SS} or V _{DD} | 5.0 | - | 0.05 | - | 0.05 | - | 0.05 | V |
| | | | 10 | - | 0.05 | - | 0.05 | - | 0.05 | |
| | | | 15 | - | 0.05 | - | 0.05 | - | 0.05 | |
| I _{IL} | Low -Level Input Current | V _I = V _{SS} | 18 | - | -0.1 | - | -0.1 | - | -1.0 | μA |
| I _{IH} | High -Level Input Current | V _I = V _{DD} | 18 | - | 0.1 | - | 0.1 | - | 1.0 | μA |
| I _{DD} | Quiescent Devices Current | V _I = V _{SS} or V _{DD} | 5.0 | - | 5.0 | - | 5.0 | - | 150 | μA |
| | | | 10 | - | 10 | - | 10 | - | 300 | |
| | | | 15 | - | 20 | - | 20 | - | 600 | |
| | | | 20 | - | 100 | - | 100 | - | 3000 | |
| I _{OL} | Output Low (Sink) Current | V _I = V _{SS} or V _{DD} V _{OL} = 0.4 V V _{OL} = 0.5 V V _{OL} = 1.5 V | 5.0 | 0.64 | - | 0.51 | - | 0.36 | - | mA |
| | | | 10 | 1.6 | - | 1.3 | - | 0.9 | - | |
| | | | 15 | 4.2 | - | 3.4 | - | 2.4 | - | |
| | | | | | | | | | | |
| I _{OH} | Output High (Source) Current | V _I = V _{SS} or V _{DD} V _{OH} = 2.5 V V _{OH} = 4.6 V V _{OH} = 9.5 V V _{OH} = 13.5 V | 5.0 | -1.6 | - | -1.3 | - | -0.9 | - | mA |
| | | | 5.0 | -0.46 | - | -0.37 | - | -0.26 | - | |
| | | | 10 | -0.98 | - | -0.8 | - | -0.55 | - | |
| | | | 15 | -3.33 | - | -2.7 | - | -1.9 | - | |

DYNAMIC ELECTRICAL CHARACTERISTICS ($C_L=50$ pF, $R_L = 200$ kOhm, $t_{LH} = t_{HL} \leq 20$ ns)

| Symbol | Parameter | Test conditions | $V_{DD},$ V | Guaranteed Limits | | | | | | Unit |
|-----------|--|----------------------------------|----------------|-------------------|------|-------|------|--------|------|------|
| | | | | -55 °C | | 25 °C | | 125 °C | | |
| | | | | min | max | min | max | min | max | |
| t_{PHL} | Propagation Delay Time High-to-Low Level Input (A-D) | Time diagram on the figure | 5.0 | - | 1040 | - | 1040 | - | 2080 | nc |
| | | | 10 | - | 420 | - | 420 | - | 840 | |
| | | | 15 | - | 300 | - | 300 | - | 600 | |
| | Propagation Delay Time High-to-Low Level Input BL | Time diagram on the figure | 5.0 | - | 700 | - | 700 | - | 1400 | |
| | | | 10 | - | 350 | - | 350 | - | 700 | |
| | | | 15 | - | 250 | - | 250 | - | 500 | |
| | Propagation Delay Time High-to-Low Level Input LT | Time diagram on the figure | 5.0 | - | 500 | - | 500 | - | 1000 | |
| | | | 10 | - | 250 | - | 250 | - | 500 | |
| | | | 15 | - | 170 | - | 170 | - | 340 | |
| t_{PLH} | Propagation Delay Time Low-to-High Level Input (A-D) | Time diagram on the figure | 5.0 | - | 1320 | - | 1320 | - | 2640 | nc |
| | | | 10 | - | 520 | - | 520 | - | 1040 | |
| | | | 15 | - | 360 | - | 360 | - | 720 | |
| | Propagation Delay Time Low-to-High Level Input BL | Time diagram on the figure | 5.0 | - | 800 | - | 800 | - | 1600 | |
| | | | 10 | - | 350 | - | 350 | - | 700 | |
| | | | 15 | - | 300 | - | 300 | - | 600 | |
| | Propagation Delay Time Low-to-High Level Input LT | Time diagram on the figure | 5.0 | - | 300 | - | 300 | - | 600 | |
| | | | 10 | - | 150 | - | 150 | - | 300 | |
| | | | 15 | - | 100 | - | 100 | - | 200 | |
| t_{THL} | Transition Time High-to-Low Level | Time diagram on the figure | 5.0 | - | 310 | - | 310 | - | 620 | nc |
| | | | 10 | - | 185 | - | 185 | - | 370 | |
| | | | 15 | - | 160 | - | 160 | - | 320 | |
| t_{TLH} | Transition Time Low-to-High Level | Time diagram on the figure | 5.0 | - | 80 | - | 80 | - | 160 | nc |
| | | | 10 | - | 60 | - | 60 | - | 120 | |
| | | | 15 | - | 50 | - | 50 | - | 100 | |
| t_{SU} | Set-Up Time (A-D) as per LE | Time diagram on the figure | 5.0 | 150 | - | 150 | - | 300 | - | nc |
| | | | 10 | 70 | - | 70 | - | 140 | - | |
| | | | 15 | 40 | - | 40 | - | 80 | - | |
| t_H | Hold Time (A - D) after LE | Time diagram on the figure | 5.0 | 0 | - | 0 | - | 0 | - | nc |
| | | | 10 | 0 | - | 0 | - | 0 | - | |
| | | | 15 | 0 | - | 0 | - | 0 | - | |
| t_{WL} | LE Pulse Width | Time diagram on the figure | 5.0 | 400 | - | 400 | - | 800 | - | nc |
| | | | 10 | 160 | - | 160 | - | 320 | - | |
| | | | 15 | 100 | - | 100 | - | 200 | - | |

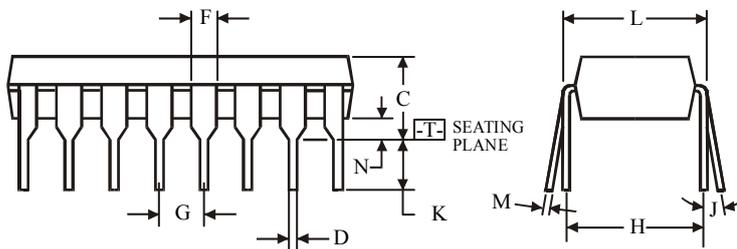
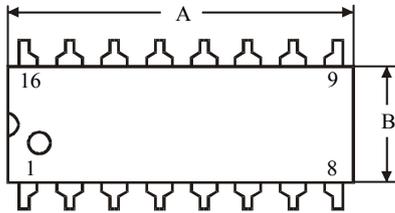
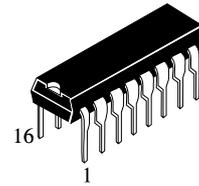
CAPACITANCE

| Symbol | Parameter | V_{DD} , v | Guaranteed Limits | | Unit |
|----------|-------------------|-----------------|-------------------|-----|------|
| | | | min | max | |
| C_{IN} | Input Capacitance | - | - | 7.5 | pF |



Time diagram when taking dynamic parameters

**N SUFFIX PLASTIC DIP
(MS - 001BB)**



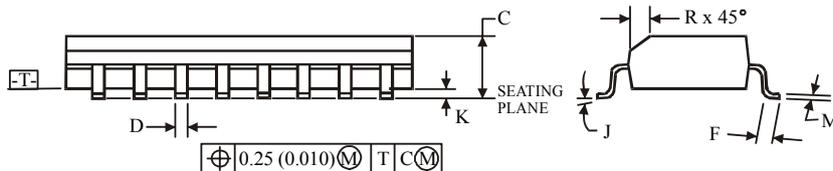
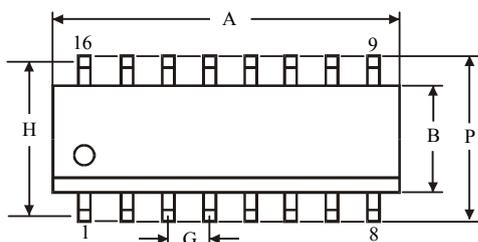
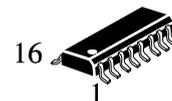
$\oplus 0.25 (0.010) \text{ (M) T}$

NOTES:

- Dimensions "A", "B" do not include mold flash or protrusions.
Maximum mold flash or protrusions 0.25 mm (0.010) per side.

| Symbol | Dimension, mm | |
|--------|---------------|-------|
| | MIN | MAX |
| A | 18.67 | 19.69 |
| B | 6.1 | 7.11 |
| C | | 5.33 |
| D | 0.36 | 0.56 |
| F | 1.14 | 1.78 |
| G | 2.54 | |
| H | 7.62 | |
| J | 0° | 10° |
| K | 2.92 | 3.81 |
| L | 7.62 | 8.26 |
| M | 0.2 | 0.36 |
| N | 0.38 | |

**D SUFFIX SOIC
(MS - 012AC)**



$\oplus 0.25 (0.010) \text{ (M) T C (M)}$

NOTES:

- Dimensions A and B do not include mold flash or protrusion.
- Maximum mold flash or protrusion 0.15 mm (0.006) per side for A; for B - 0.25 mm (0.010) per side.

| Symbol | Dimension, mm | |
|--------|---------------|------|
| | MIN | MAX |
| A | 9.8 | 10 |
| B | 3.8 | 4 |
| C | 1.35 | 1.75 |
| D | 0.33 | 0.51 |
| F | 0.4 | 1.27 |
| G | 1.27 | |
| H | 5.72 | |
| J | 0° | 8° |
| K | 0.1 | 0.25 |
| M | 0.19 | 0.25 |
| P | 5.8 | 6.2 |
| R | 0.25 | 0.5 |